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FAIRCHILD SEMICONDUCTOR™

February 1990
Revised November 1999

100395
Low Power 9-Bit ECL-to-TTL Translator with Registers

General Description

The 100395 is a 9-bit translator for converting F100K logic levels to TTL logic levels. A HIGH on the output enable ($\overline{OE}$) holds the TTL outputs in a high impedance state. Two separate clock inputs are available for multiplexing and system level testing.

The 100395 is designed with TTL 64 mA outputs for bus driving capability. All inputs have 50 kΩ pull down resistors. When the inputs are either unconnected or at the same potential, the outputs will go LOW.

Features

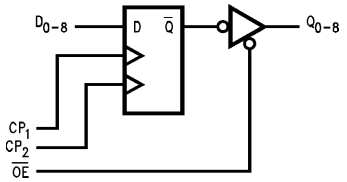
- 64 mA I_{OL} drive capability
- 2000V ESD protection
- –4.2V to –5.7V operating range
- Registered outputs
- TTL outputs

Ordering Code:

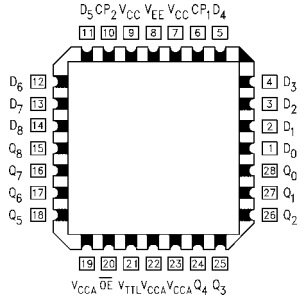
Order Number	Package Number	Package Description
100395QC	V28A	28-Lead Plastic Lead Chip Carrier (PLCC), JEDEC MO-047, 0.450 Square

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Logic Symbol



Connection Diagram



Pin Descriptions

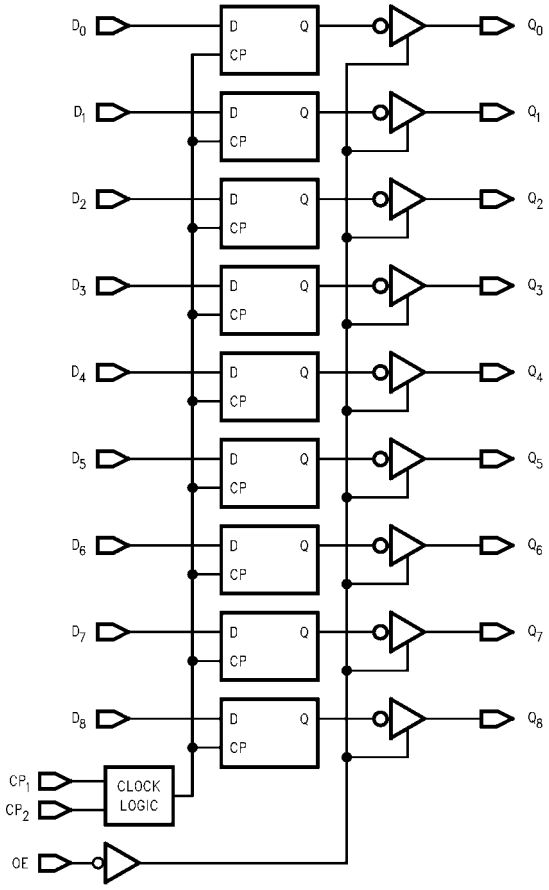
Pin Names	Description
D_0–D_8	Data Inputs (ECL)
Q_0–Q_8	Data Outputs (TTL)
$\overline{OE}$	Output Enable (ECL)
CP_1, CP_2	Clock Inputs (ECL)

Truth Table

Inputs				Outputs
CP_1	CP_2	$\overline{OE}$	D_N	Q_N
↗	L	L	L	L
L	↗	L	L	L
↗	L	L	H	H
L	↗	L	H	H
H	X	X	X	NC
X	H	X	X	NC
L	L	X	X	NC
X	X	H	X	Z

H = HIGH Voltage Level
L = LOW Voltage Level
X = Don't Care
Z = High Impedance
NC = No Change

Logic Diagram



Absolute Maximum Ratings(Note 1)

Storage Temperature (T_{STG})	−65°C to +150°C
Maximum Junction Temperature (T_J)	+150°C
Case Temperature under Bias (T_C)	0°C to +85°C
V_{EE} Pin Potential to Ground Pin	−7.0V to +0.5V
V_{TTL} Pin Potential to Ground Pin	−0.5V to +6.0V
ECL Input Voltage (DC)	V_{EE} to +0.5V
TTL Input Voltage	−0.5V to +7.0V
Output Current	
(DC Output HIGH)	+130 mA
ESD (Note 2)	≥ 2000V

Recommended Operating Conditions

Case Temperature (T_C)	0°C to +85°C
Supply Voltage	
V_{EE}	−5.7V to −4.2V
V_{TTL}	+4.5V to +5.5V

Note 1: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the absolute maximum rating. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

Note 2: ESD testing conforms to MIL-STD-883, Method 3015.

Commercial Version

DC Electrical Characteristics (Note 3)

V_{EE} = −4.2V to −5.7V, V_{CC} = V_{CCA} = GND, T_C = 0°C to +85°C

Symbol	Parameter	Min	Typ	Max	Units	Conditions	
V_{OH}	Output HIGH Voltage	2.4			V	I_{OH} = −15 mA	V_{IN} = V_{IH} (Max)
V_{OL}	Output LOW Voltage			0.55	V	I_{OL} = 64 mA	or V_{IL} (Min)
V_{IH}	Input HIGH Voltage	−1165		−870	mV	Guaranteed HIGH Signal for All Inputs	
V_{IL}	Input LOW Voltage	−1830		−1475	mV	Guaranteed LOW Signal for All Inputs	
I_{IL}	Input LOW Current	0.5			µA	V_{IN} = V_{IL} (Min)	
I_{IH}	Input HIGH Current			240	µA	V_{IN} = V_{IH} (Max)	
I_{OZL}	3-STATE Current Output HIGH			−50	µA	V_{OUT} = +0.4V	
I_{OZH}	3-STATE Current Output LOW			+50	µA	V_{OUT} = +2.7V	
I_{CEX}	Output HIGH Leakage Current			250	µA	V_{OUT} = V_{CC}	
I_{OS}	Output Short-Circuit Current	−100		−225	mA		
I_{EE}	V_{EE} Power Supply Current	−67		−29	mA	Inputs OPEN	
I_{CCH}	V_{TTL} Power Supply Current HIGH			29	mA		
I_{CCL}	V_{TTL} Power Supply Current LOW			65	mA		
I_{CCZ}	V_{TTL} Power Supply Current 3-STATE			49	mA		

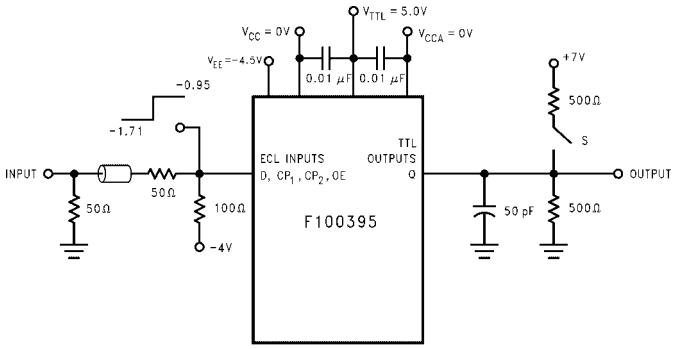
Note 3: The specified limits represent the "worst case" value for the parameter. Since these values normally occur at the temperature extremes, additional noise immunity and guardbanding can be achieved by decreasing the allowable system operating ranges. Conditions for testing shown in the tables are chosen to guarantee operation under "worst case" conditions.

PLCC AC Electrical Characteristics

V_{EE} = −4.2V to −5.7V, V_{CC} = GND, V_{TTL} = +4.5V to +5.5V

Symbol	Parameter	T_C = 0°C		T_C = +25°C		T_C = +85°C		Units	Conditions
		Min	Max	Min	Max	Min	Max		
t_{PLH}	Propagation Delay	2.30	5.00	2.30	5.00	2.30	5.00	ns	Figures 1, 2
t_{PHL}	Clock to Output	3.00	5.60	3.00	5.60	3.40	6.40		
t_{PZL}	Output Enable Time	3.20	7.60	3.20	7.60	3.20	7.60	ns	Figures 1, 3
t_{PZH}	$\overline{OE}$ ↓ to Q_N	2.40	5.60	2.40	5.60	2.40	5.60		
t_{PLZ}	Output Disable Time	3.20	7.60	3.20	7.60	3.20	7.60	ns	Figures 1, 3
t_{PHZ}	$\overline{OE}$ ↑ to Q_N	2.40	5.60	2.40	5.60	2.40	5.60		
t_H	Data to CP $\overline{EN}$	1.5		1.5		1.5		ns	Figures 1, 2
	Hold Time	1.5		1.5		1.5			
t_S	Data to CP $\overline{EN}$	0.5		0.5		0.5		ns	Figures 1, 2
	Setup Time	0.5		0.5		0.5			
t_{PW}(H)	Clock Pulse Width	2.0		2.0		2.0		ns	Figures 1Figure 2

Test Circuit



Notes:

V_{CC} = 0V, V_{CCA} = 0V, V_{EE} = −4.5V, V_{TTL} = +5V.

All unused outputs are loaded with 500Ω to GND. Decoupling capacitors are necessary in the test and end application environment. When V_{CC} and V_{CCA} are common to a single power plane, typically 0.0V, decouple V_{TTL} to that plane with one 0.01 µF capacitor.

FIGURE 1. AC Test Circuit

Switch Positions for Parameter Testing

Parameter	S-Position
t_{PLH}, t_{PHL}	Open
t_{PHZ}, t_{PZH}	Open
t_{PLZ}, t_{PZL}	Closed

Switching Waveforms

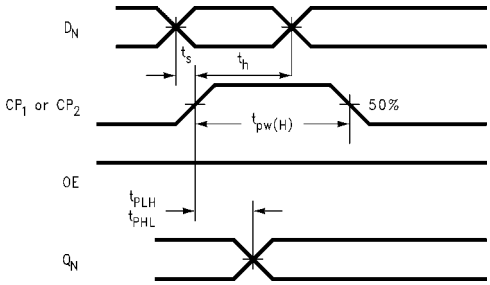


FIGURE 2. Propagation Delay and Transition Times

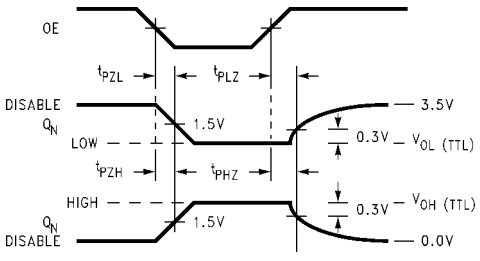
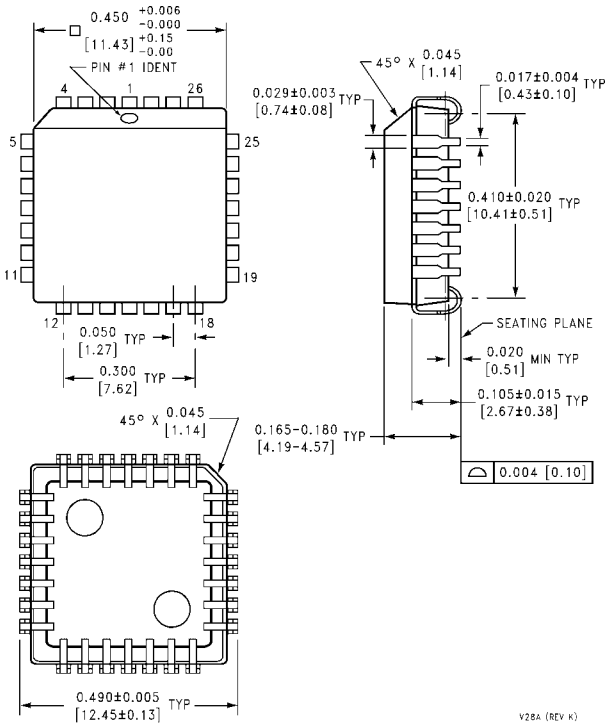


FIGURE 3. Enable and Disable Waveforms, $\overline{OE}$ to Q_N

Physical Dimensions inches (millimeters) unless otherwise noted



28-Lead Plastic Lead Chip Carrier (PLCC), JEDEC MO-047, 0.450 Square
Package Number V28A